DATA SHEET

74LV174

Hex D-type flip-flop with reset; positive-edge trigger

Product specification
Supersedes data of 1997 Apr 07
IC24 Data Handbook

1998 May 20

Philips
Semiconductors

PHILIPS

Hex D-type flip-flop with reset; positive edge-trigger 74LV174

FEATURES

- Wide operating voltage: 1.0 to 5.5V
- Optimized for Low Voltage applications: 1.0 to 3.6V
- Accepts TTL input levels between V_{CC} = 2.7V and V_{CC} = 3.6V
- Typical V_{OLP} (output ground bounce) $< 0.8V$ @ V_{CC} = 3.3V, T_{amb} = 25°C
- Typical V_{OHV} (output V_{OH} undershoot) $> 2V$ @ V_{CC} = 3.3V, T_{amb} = 25°C
- Output capability: standard
- I_{CC} category: MSI

DESCRIPTION

The 74LV174 is a low–voltage Si–gate CMOS device and is pin and function compatible with the 74HC/HCT174.

The 74LV174 has six edge–triggered D–type flip–flops with individual D inputs and Q outputs. The common clock (CP) and master reset (MR) inputs load and reset (clear) all flip–flops simultaneously.

The register is fully edge–triggered. The state of each D input, one set–up time prior to the LOW–to–HIGH clock transition, is transferred to the corresponding output of the flip–flop.

A LOW level on the MR input forces all outputs LOW, independently of clock or data inputs.

The device is useful for applications requiring true outputs only and clock and master reset inputs that are common to all storage elements.

QUICK REFERENCE DATA

GND = 0V; T_{amb} = 25°C; $t_r = t_f \leq 2.5$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t_{PHL}/t_{PLH}	Propagation delay CP to Q_n $\overline{MR}$ to Q_n	C_L = 15pF V_{CC} = 3.3V	16 13	ns
f_{max}	Maximum clock frequency		77	MHz
C_I	Input capacitance		3.5	pF
C_{PD}	Power dissipation capacitance per flip-flop	V_{CC} = 3.3V Notes 1 and 2	17	pF

NOTES:

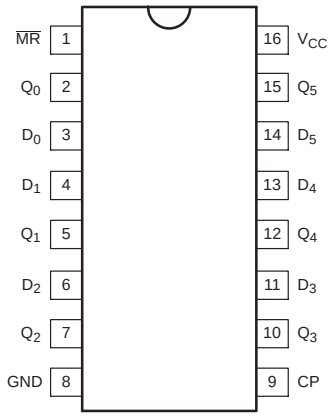
1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW)
   $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:
   f_i = input frequency in MHz; C_L = output load capacitance in pF;
   f_o = output frequency in MHz; V_{CC} = supply voltage in V;
   $\Sigma (C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.
2. The condition is V_I = GND to V_{CC}

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
16-Pin Plastic DIL	–40°C to +125°C	74LV174 N	74LV174 N	SOT38-4
16-Pin Plastic SO	–40°C to +125°C	74LV174 D	74LV174 D	SOT109-1
16-Pin Plastic SSOP Type II	–40°C to +125°C	74LV174 DB	74LV174 DB	SOT338-1
16-Pin Plastic TSSOP	–40°C to +125°C	74LV174 PW	74LV174PW DH	SOT403-1

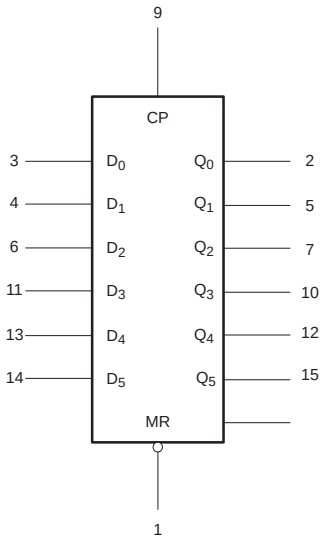
Hex D-type flip-flop with reset; positive edge-trigger 74LV174

PIN CONFIGURATION



SV00347

LOGIC SYMBOL



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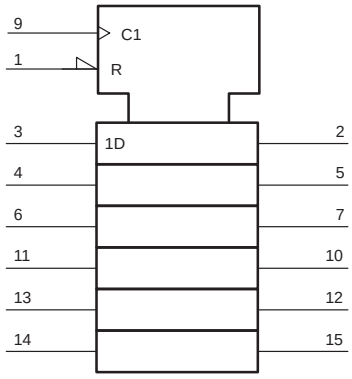
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1	$\overline{MR}$	Asynchronous master reset (active LOW)
2, 5, 7, 10, 12, 15	Q_0 to Q_5	Flip-flop outputs
3, 4, 6, 11, 13, 14	D_0 to D_5	Data inputs
8	GND	Ground (0V)
9	CP	Clock input (LOW-to-HIGH, edge-triggered)
16	V_{CC}	Positive supply voltage

LOGIC SYMBOL (IEEE/IEC)



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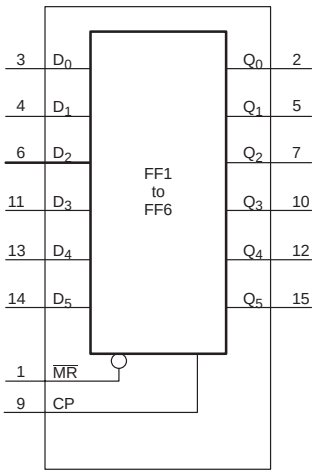
FUNCTIONAL DIAGRAM



SV00350

FUNCTION TABLE

OPERATING MODES	INPUTS			OUTPUTS
	$\overline{MR}$	CP	D_n	Q_0
Reset (clear)	L	X	X	L
Load '1'	H	↑	h	H
Load '0'	H	↑	l	L

H = HIGH voltage level
h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition
L = LOW voltage level
l = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition
q = Lower case letter indicates the state of referenced input one set-up time prior to the LOW-to-HIGH CP transition
↑ = LOW–to–HIGH clock transition

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
V_{CC}	DC supply voltage	See Note1	1.0	3.3	5.5	V
V_I	Input voltage		0	–	V_{CC}	V
V_O	Output voltage		0	–	V_{CC}	V
T_{amb}	Operating ambient temperature range in free air	See DC and AC characteristics	–40 –40		+85 +125	°C
t_r, t_f	Input rise and fall times	V_{CC} = 1.0V to 2.0V V_{CC} = 2.0V to 2.7V V_{CC} = 2.7V to 3.6V V_{CC} = 3.6V to 5.5V	– – – –	– – – –	500 200 100 50	ns/V

NOTES:
1. The LV is guaranteed to function down to V_{CC} = 1.0V (input levels GND or V_{CC}); DC characteristics are guaranteed from V_{CC} = 1.2V to V_{CC} = 5.5V.

ABSOLUTE MAXIMUM RATINGS[1, 2]

In accordance with the Absolute Maximum Rating System (IEC 134)
Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		–0.5 to +7.0	V
$\pm I_{IK}$	DC input diode current	$V_I < –0.5$ or $V_I > V_{CC} + 0.5V$	20	mA
$\pm I_{OK}$	DC output diode current	$V_O < –0.5$ or $V_O > V_{CC} + 0.5V$	50	mA
$\pm I_O$	DC output source or sink current – standard outputs	$–0.5V < V_O < V_{CC} + 0.5V$	25	mA
$\pm I_{GND}$, $\pm I_{CC}$	DC V_{CC} or GND current for types with –standard outputs		50	mA
T_{stg}	Storage temperature range		–65 to +150	°C
P_{TOT}	Power dissipation per package –plastic DIL –plastic mini-pack (SO) –plastic shrink mini-pack (SSOP and TSSOP)	for temperature range: –40 to +125°C above +70°C derate linearly with 12mW/K above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	 750 500 400	mW

NOTES:
1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

DC CHARACTERISTICS FOR THE LV FAMILY

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			-40°C to +85°C			-40°C to +125°C		
			MIN	TYP[1]	MAX	MIN	MAX	
V_{IH}	HIGH level Input voltage	V_{CC} = 1.2V	0.9			0.9		V
		V_{CC} = 2.0V	1.4			1.4		
		V_{CC} = 2.7 to 3.6V	2.0			2.0		
		V_{CC} = 4.5 to 5.5V	0.7*V_{CC}			0.7*V_{CC}		
V_{IL}	LOW level Input voltage	V_{CC} = 1.2V			0.3		0.3	V
		V_{CC} = 2.0V			0.6		0.6	
		V_{CC} = 2.7 to 3.6V			0.8		0.8	
		V_{CC} = 4.5 to 5.5			0.3*V_{CC}		0.3*V_{CC}	
V_{OH}	HIGH level output voltage; all outputs	V_{CC} = 1.2V; $V_I = V_{IH}$ or V_{IL}; $–I_O$ = 100µA		1.2				V
		V_{CC} = 2.0V; $V_I = V_{IH}$ or V_{IL}; $–I_O$ = 100µA	1.8	2.0		1.8		
		V_{CC} = 2.7V; $V_I = V_{IH}$ or V_{IL}; $–I_O$ = 100µA	2.5	2.7		2.5		
		V_{CC} = 3.0V; $V_I = V_{IH}$ or V_{IL}; $–I_O$ = 100µA	2.8	3.0		2.8		
		V_{CC} = 4.5V;$V_I = V_{IH}$ or V_{IL}; $–I_O$ = 100µA	4.3	4.5		4.3		
	HIGH level output voltage; STANDARD outputs	V_{CC} = 3.0V;$V_I = V_{IH}$ or V_{IL}; $–I_O$ = 6mA	2.40	2.82		2.20		V
		V_{CC} = 4.5V;$V_I = V_{IH}$ or V_{IL}; $–I_O$ = 12mA	3.60	4.20		3.50		
V_{OL}	LOW level output voltage; all outputs	V_{CC} = 1.2V; $V_I = V_{IH}$ or V_{IL}; I_O = 100µA		0				V
		V_{CC} = 2.0V; $V_I = V_{IH}$ or V_{IL}; I_O = 100µA		0	0.2		0.2	
		V_{CC} = 2.7V; $V_I = V_{IH}$ or V_{IL}; I_O = 100µA		0	0.2		0.2	
		V_{CC} = 3.0V;$V_I = V_{IH}$ or V_{IL}; I_O = 100µA		0	0.2		0.2	
		V_{CC} = 4.5V;$V_I = V_{IH}$ or V_{IL}; I_O = 100µA		0	0.2		0.2	
	LOW level output voltage; STANDARD outputs	V_{CC} = 3.0V;$V_I = V_{IH}$ or V_{IL}; I_O = 6mA		0.25	0.40		0.50	V
		V_{CC} = 4.5V;$V_I = V_{IH}$ or V_{IL}; I_O = 12mA		0.35	0.55		0.65	

DC CHARACTERISTICS FOR THE LV FAMILY (Continued)

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			-40°C to +85°C			-40°C to +125°C		
I_I	Input leakage current	V_{CC} = 5.5V; V_I = V_{CC} or GND			1.0		1.0	µA
I_{CC}	Quiescent supply current; MSI	V_{CC} = 5.5V; V_I = V_{CC} or GND; I_O = 0			20.0		160	µA
ΔI_{CC}	Additional quiescent supply current per input	V_{CC} = 2.7V to 3.6V; V_I = V_{CC} –0.6V			500		850	µA

NOTE:
1. All typical values are measured at T_{amb} = 25°C.

AC CHARACTERISTICS

GND = 0V; t_r = t_f = 2.5ns; C_L = 50pF; R_L = 1KΩ

SYMBOL	PARAMETER	WAVEFORM	CONDITION	LIMITS –40 to +85 °C			LIMITS –40 to +125 °C		UNIT
			V_{CC}(V)	MIN	TYP[1]	MAX	MIN	MAX	
t_{PHL}/t_{PLH}	Propagation delay CP to Q_n	Figure 1	1.2	–	100	–	–	–	ns
			2.0	–	34	43	–	53	
			2.7	–	25	31	–	39	
			3.0 to 3.6	–	19[2]	25	–	31	
			4.5 to 5.5	–	13[3]	21	–	26	
t_{PHL}	Propagation delay $\overline{MR}$ to Q_n	Figure 2	1.2	–	80	–	–	–	ns
			2.0	–	27	43	–	53	
			2.7	–	20	31	–	39	
			3.0 to 3.6	–	15[2]	25	–	31	
			4.5 to 5.5	–	11[3]	21	–	26	
t_W	Clock pulse width HIGH to LOW	Figure 1	2.0	34	10	–	41	–	ns
			2.7	25	8	–	30	–	
			3.0 to 3.6	20	6[2]	–	24	–	
			4.5 to 5.5	13	4[3]		16		
t_W	Master reset pulse width LOW	Figure 2	2.0	34	9	–	41	–	ns
			2.7	25	6	–	30	–	
			3.0 to 3.6	20	5	–	24	–	
			4.5 to 5.5	13	4[2]		16		
t_{rem}	Removal time $\overline{MR}$ to CP	Figure 2	1.2	–	–20	–	–	–	ns
			2.0	5	–7	–	5	–	
			2.7	5	–5	–	5	–	
			3.0 to 3.6	5	–4[2]	–	5	–	
			4.5 to 5.5	5	–3[3]		5		
t_{su}	Set-up time D_n to CP	Figure 3	1.2	–	10	–	–	–	ns
			2.0	22	4	–	26	–	
			2.7	16	3	–	19	–	
			3.0 to 3.6	13	2[2]	–	15	–	
			4.5 to 5.5	9	1[3]		10		

AC CHARACTERISTICS (Continued)

GND = 0V; $t_r = t_f$ = 2.5ns; C_L = 50pF; R_L = 1KΩ

SYMBOL	PARAMETER	WAVEFORM	CONDITION	LIMITS –40 to +85 °C			LIMITS –40 to +125 °C		UNIT
			V_{CC}(V)	MIN	TYP[1]	MAX	MIN	MAX	
t_h	Hold time D_n to CP	Figure 3	1.2	–	–10	–	–	–	ns
			2.0	5	–4	–	5	–	
			2.7	5	–2	–	5	–	
			3.0 to 3.6	5	–2[2]	–	5	–	
			4.5 to 5.5	5	–1[3]		5		
f_{max}	Maximum clock pulse frequency	Figure 1	2.0	14	40	–	12	–	MHz
			2.7	19	58	–	16	–	
			3.0 to 3.6	24	70[2]	–	20	–	
			4.5 to 5.5	36	100[3]		30		

NOTES:

1. Unless otherwise stated, all typical values are at T_{amb} = 25°C.
2. Typical value measured at V_{CC} = 3.3V.
3. Typical value measured at V_{CC} = 5.0V.

AC WAVEFORMS

V_M = 1.5V at $V_{CC} \geq$ 2.7V $\leq$ 3.6V

V_M = 0.5V * V_{CC} at V_{CC} < 2.7V and $\geq$ 4.5V

V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

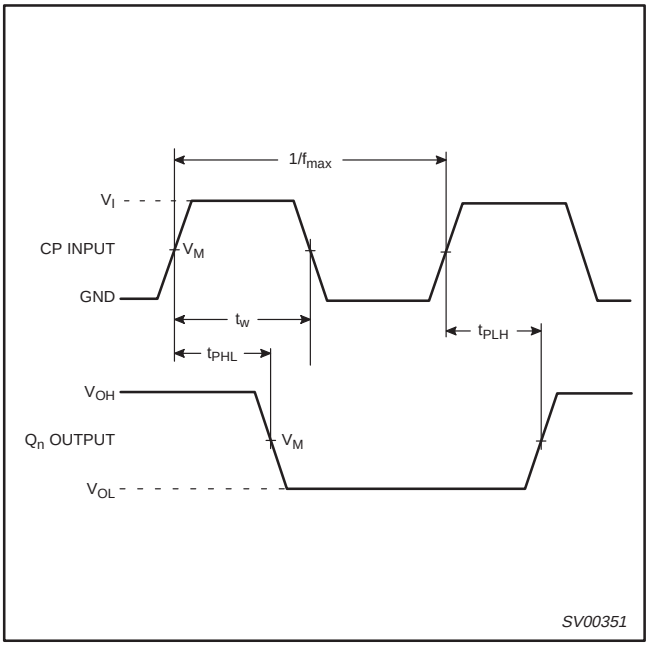


Figure 1. The clock (CP) to output (Q_n) propagation delays, the clock pulse width, and the maximum clock pulse frequency.

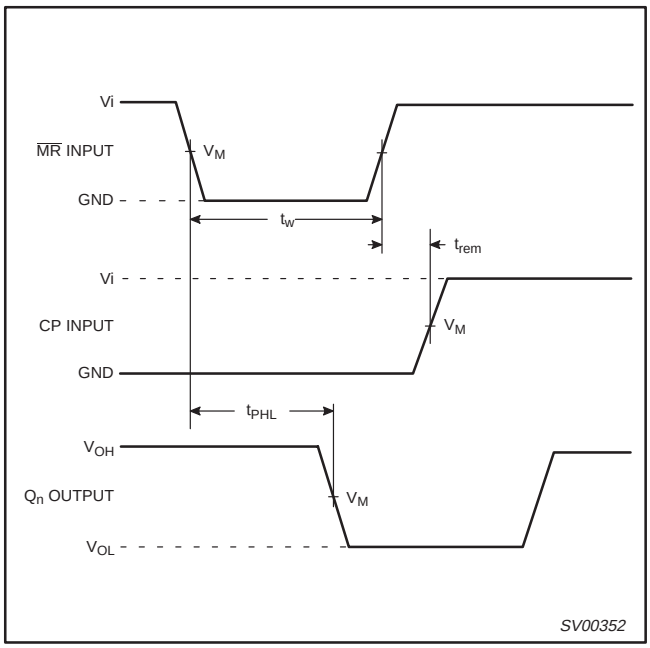


Figure 2. The master reset ($\overline{MR}$) pulse width, the master reset to output (Q_n) propagation delay and the master reset to clock removal time.

AC WAVEFORMS (Continued)

V_M = 1.5V at $V_{CC} \geq 2.7V \leq 3.6V$
V_M = 0.5V * V_{CC} at $V_{CC} < 2.7V$ and $\geq 4.5V$
V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

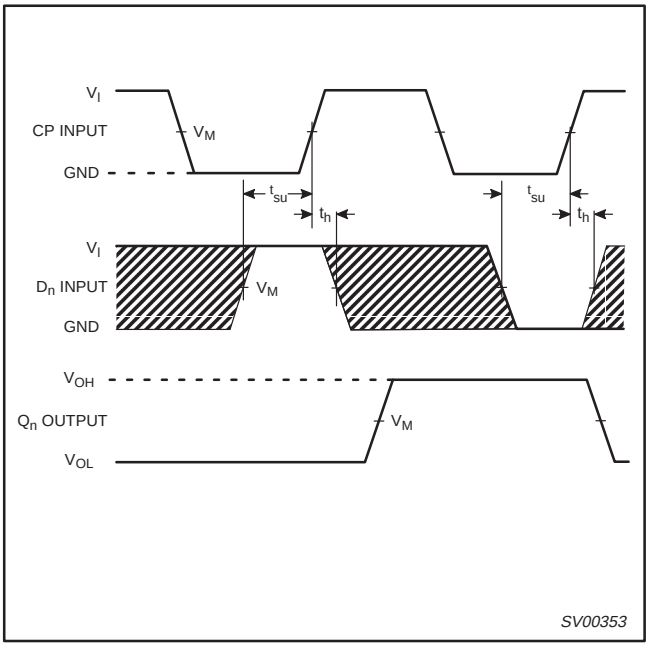


Figure 3. Data set-up and hold times for the data input ($D_{n)}$.

NOTE:
The shaded areas indicate when the input is permitted to change for predictable output performance.

TEST CIRCUIT

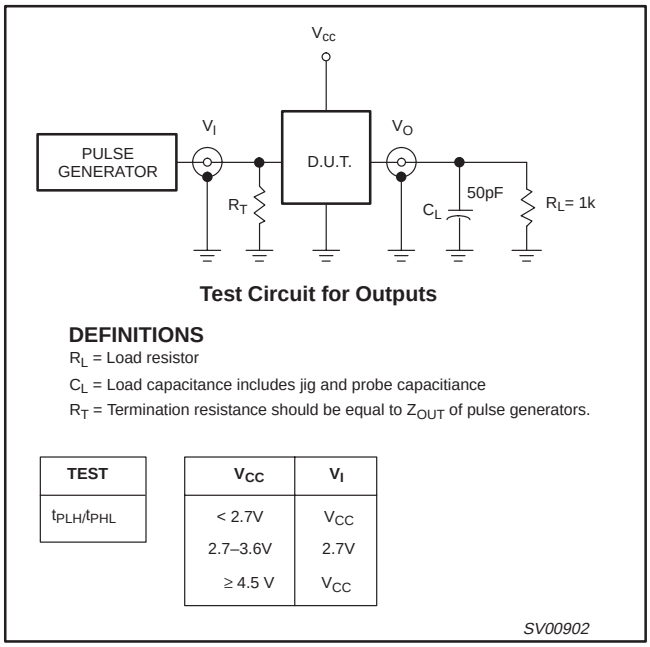
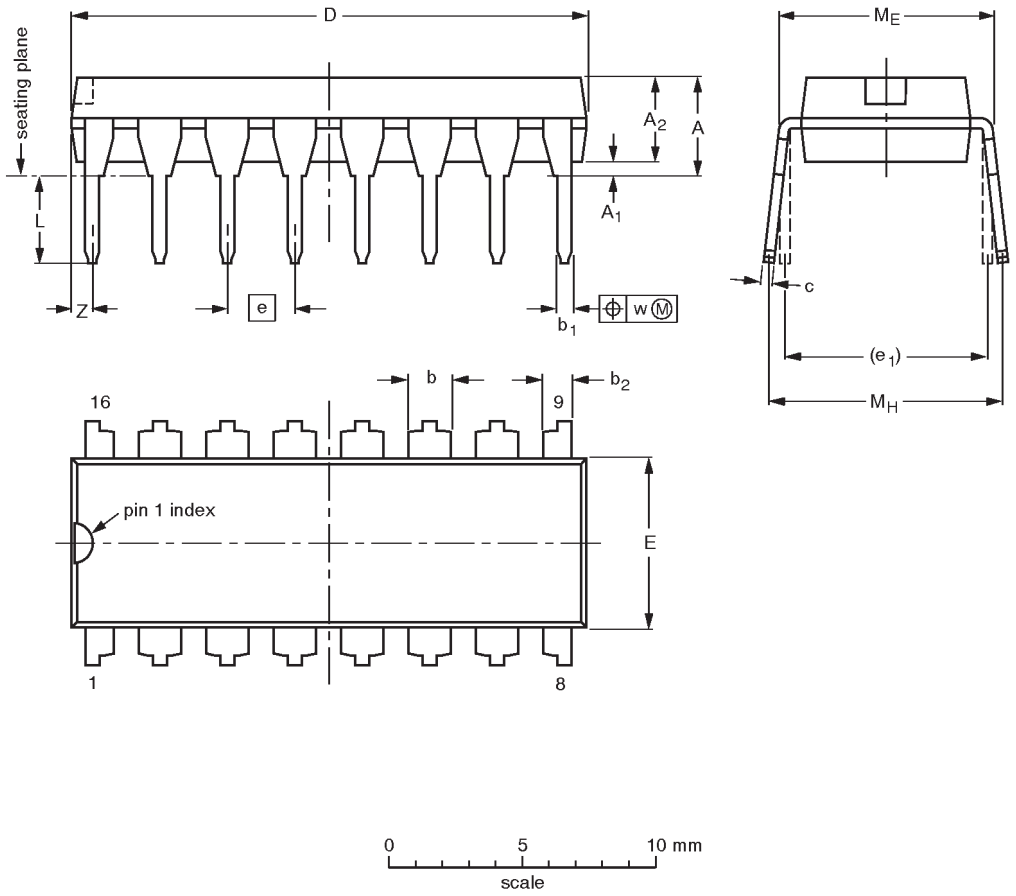


Figure 4. Load circuitry for switching times

DIP16: plastic dual in-line package; 16 leads (300 mil) **SOT38-4**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

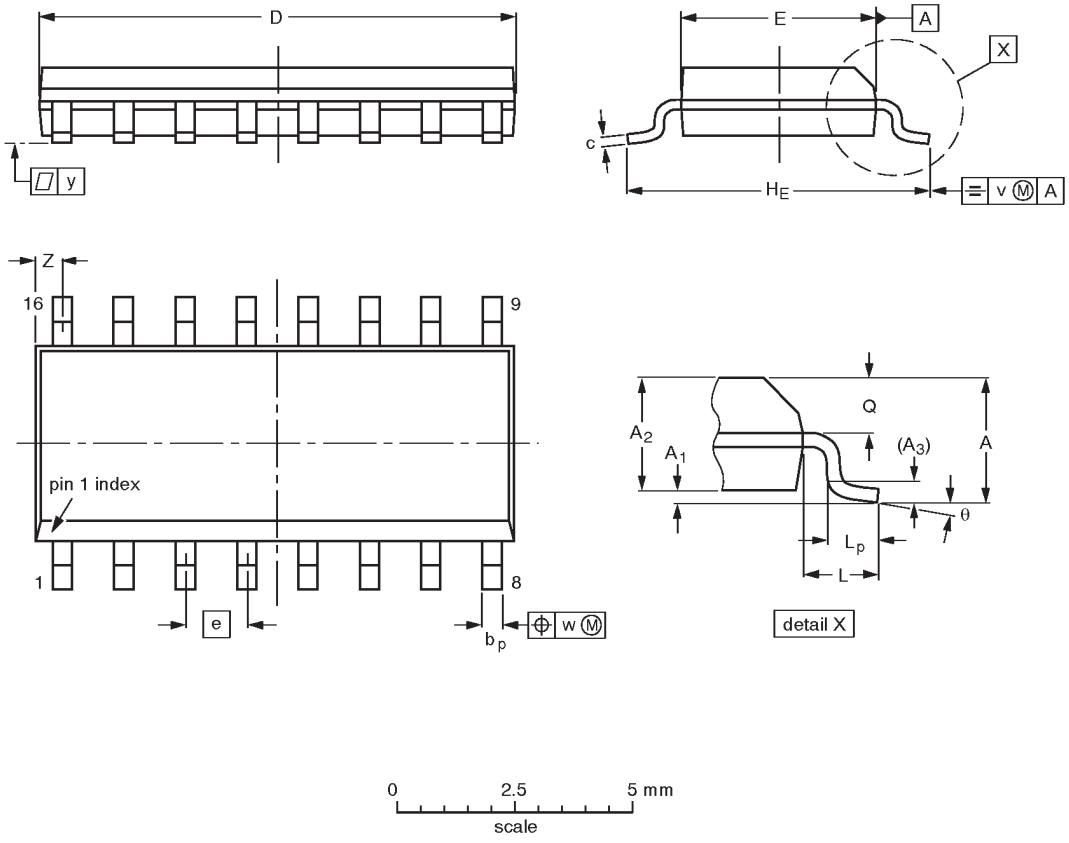
UNIT	A max.	A_1 min.	A_2 max.	b	b_1	b_2	c	$D^{(1)}$	$E^{(1)}$	e	e_1	L	M_E	M_H	w	$Z^{(1)}$ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT38-4						~~92-11-17~~ 95-01-14

SO16: plastic small outline package; 16 leads; body width 3.9 mm **SOT109-1**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

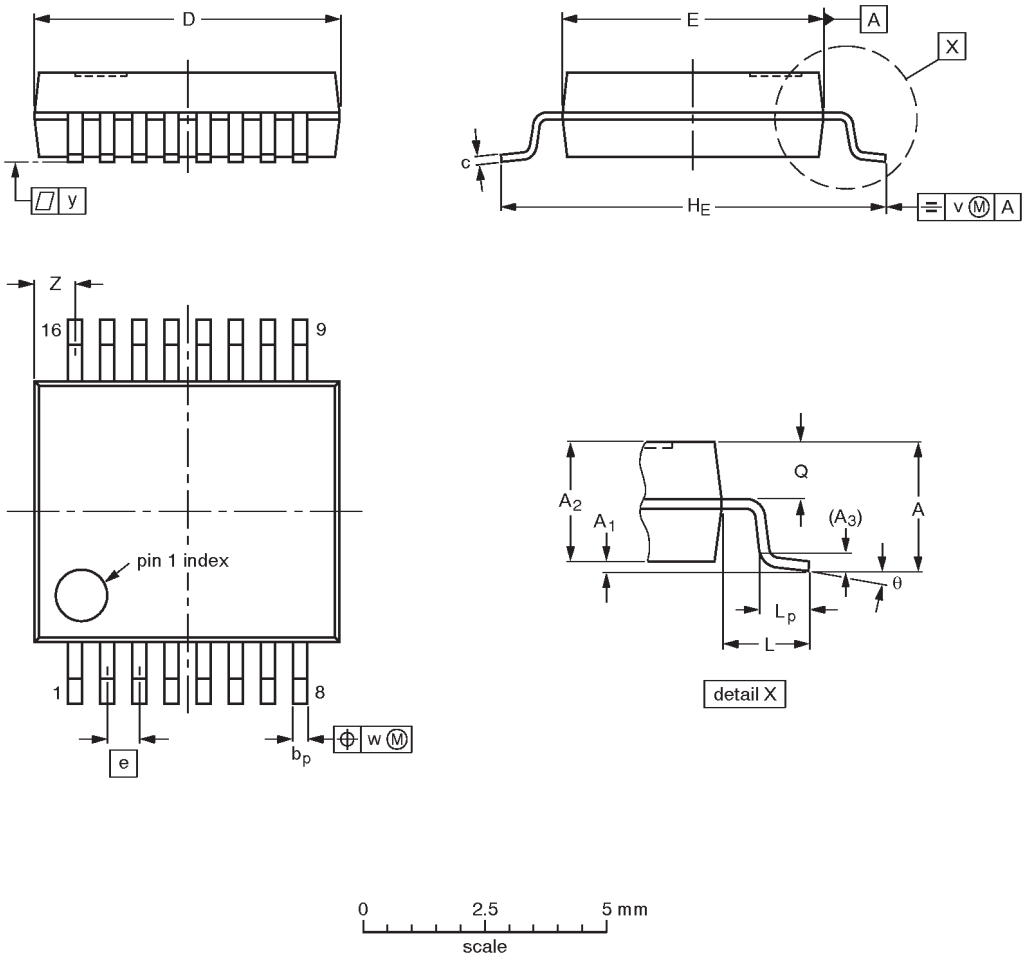
UNIT	A max.	A_1	A_2	A_3	b_p	c	$D^{(1)}$	$E^{(1)}$	e	H_E	L	L_p	Q	v	w	y	$Z^{(1)}$	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8° 0°
inches	0.069	0.0098 0.0039	0.057 0.049	0.01	0.019 0.014	0.0098 0.0075	0.39 0.38	0.16 0.15	0.050	0.24 0.23	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT109-1	076E07S	MS-012AC				~~91-08-13~~ 95-01-23

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm **SOT338-1**



DIMENSIONS (mm are the original dimensions)

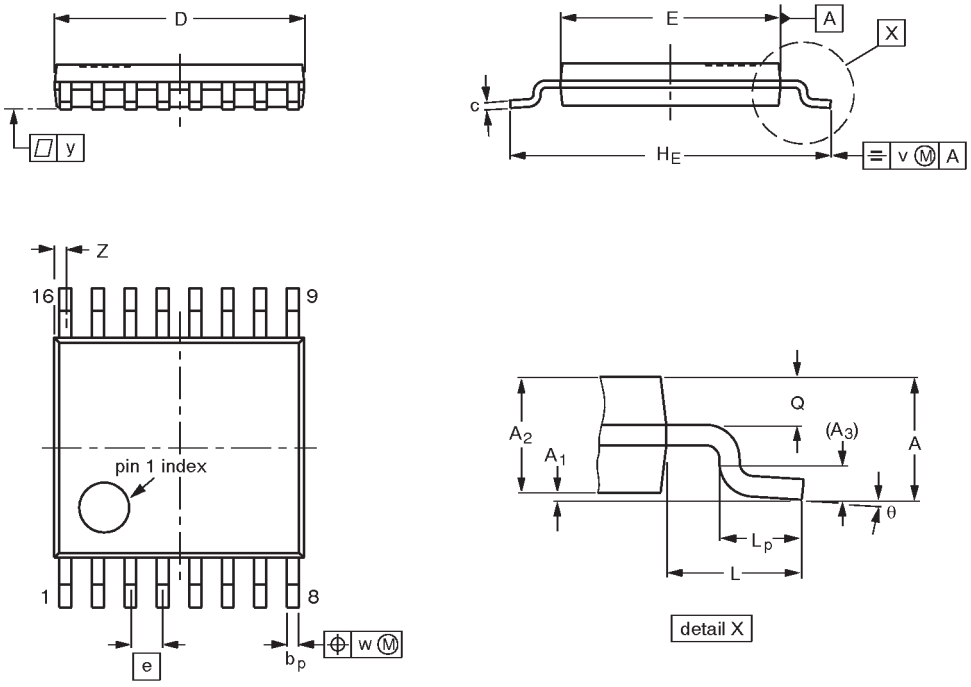
UNIT	A max.	A_1	A_2	A_3	b_p	c	D (1)	E (1)	e	H_E	L	L_p	Q	v	w	y	Z (1)	θ
mm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.00 0.55	8° 0°

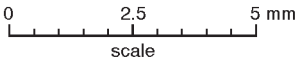
Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT338-1		MO-150AC				~~94-01-14~~ 95-02-04

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm **SOT403-1**





DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	D (1)	E (2)	e	H_E	L	L_p	Q	v	w	y	Z (1)	θ
mm	1.10	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT403-1		MO-153				~~94-07-12~~ 95-04-04

NOTES

DEFINITIONS

Data Sheet Identification	Product Status	Definition
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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